









FCC&IC RF Test Report

Product Name: M2M Module

Model Number: MU509-65

Report No: SYBH(Z-RF)018012016-2001

FCC ID: QISMU509-65

IC: 6369A-MU50965

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Notice

- 1. The laboratory has Passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
- 2. The laboratory has Passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
- 3. The laboratory has been listed by the US Federal Communications Commission to perform electromagnetic emission measurements. The site recognition number is 97456.
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- 8. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- "The laboratory (Reliability Lab of Huawei Technologies Co., Ltd) is also named as "Global Compliance and Testing Center of Huawei Technologies Co., Ltd", the both names have coexisted since 2009.

Applicant: Huawei Technologies Co., Ltd. Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C **Date of Receipt Sample:** 2016-01-18 **Start Date of Test:** 2016-01-18 **End Date of Test:** 2016-01-23 **Test Result: Pass** Lin Churlin **Approved by Senior** Liu Chunlin 2016-01-26 **Engineer:** Date Name Signature

2016-01-26

Date

Prepared by:

Feng Nianwei

Name

Signature



Modification Record

No.	Last Report No.	Modification Description		
1		First report.		



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1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 02:2014

47 CFR FCC Part 22: 2014 47 CFR FCC Part 24: 2014

IC RSS-Gen Issue 4, IC RSS-132 Issue 3, IC RSS-133 Issue 6,

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v02r02

1.2 Test Location

Test Location: Reliability Laboratory of Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C

Ambient Relative Humidity: 40 to 55 %

Atmospheric Pressure: Not applicable



2 Test Summary

2.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

Test Item	FCC Rule No.	IC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	RSS-Gen, §6.12; RSS-132, §5.4	FCC: ERP ≤ 7 W. IC: EIRP ≤ 11.5 W.	Appendix A	Pass
Peak-Average Ratio		RSS-132, §5.4	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	RSS-132, §5.2	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	RSS-Gen, §6.6	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §22.917	RSS-Gen, §6.13; RSS-132, §5.5	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass
Spurious \$2.1051, \$22.917 RSS-Gen, \$6.13; RSS-132, §5.5 IC: ≤ -13 MHz Terminals EBW > harmo		FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges. IC: ≤ -13 dBm/100 kHz (for EBW ≤ 4 MHz) or ≤ -13 dBm/1 MHz (for EBW > 4 MHz), from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	Pass	
Field Strength of Spurious Radiation	§2.1053, §22.917	RSS-Gen, §6.13; RSS-132, §5.5	FCC: \leq -13 dBm/100 kHz. IC: \leq -13 dBm/100 kHz (for EBW \leq 4 MHz) or \leq -13 dBm/1 MHz (for EBW > 4 MHz).	Appendix G	Pass
Frequency Stability	§2.1055, §22.355	RSS-Gen, §6.11 RSS-132, §5.3	≤ ±2.5ppm.	Appendix H	Pass
NOTE 1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".					



2.2 PCS Band (1850-1915 MHz paired with 1930-1995 MHz)

Test Item	FCC Rule No.	IC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	RSS-Gen, §6.12; RSS-133, §6.4	EIRP ≤ 2 W	Appendix A	Pass
Peak-Average Ratio	§2.1046, §24.232	RSS-133, §6.4	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	RSS-133, §6.2	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	RSS-Gen, §6.6	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §24.238	RSS-Gen, §6.13; RSS-133, §6.5	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238	RSS-Gen, §6.13; RSS-133, §6.5	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238	RSS-Gen, §6.13; RSS-133, §6.5	≤ -13 dBm/1 MHz.	Appendix G	Pass
Frequency Stability	§2.1055, §24.235	RSS-Gen, §6.11 RSS-133, §6.3	IC: ≤ ±2.5 ppm.	Appendix H	Pass
NOTE 1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".					



3 <u>Description of the Equipment under Test (EUT)</u>

3.1 General Description

MU509-65 WCDMA (UMTS) multimode Wireless Module is subscriber equipment in the UMTS system. MU509-65 implement such functions as RF signal receiving/transmitting, WCDMA protocol processing, data service etc.

3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 **Board**

Board				
Description	Hardware Version	Software Version		
Main Board	MD2MU509 Ver.A	11.815.01.11.00		



3.3 Technical Specification

Characteristics	Description				
Radio System Type	□ UMTS □				
Supported Frequency Range	WCDMA850	Transmission (TX):	824 to 849 MHz		
	WCDIVIA050	Receiving (RX):	869 to 894 MHz		
	WCDMA1900	Transmission (TX):	1850 to 1910 MHz		
	WCDIMA 1900	Receiving (RX):	1930 to 1990 MHz		
TX and RX Antenna Ports	TX & RX port:	1			
	TX-only port:	0			
	RX-only port:	1			
Target TX Output Power	UMTS850 23.5dBm				
	UMTS1900: 23.5dBm				
Supported Channel Bandwidth	UMTS system:	⊠ 5 MHz			
Designation of Emissions	UMTS850:	4M14F9W			
(Note: the necessary bandwidth of	UMTS1900:	4M16F9W			
which is the worst value from the					
measured occupied bandwidths for					
each type of channel bandwidth					
configuration.)					



4 General Test Conditions / Configurations

4.1 Test Modes

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

Test Mode	Test Modes Description			
UMTS/TM1	WCDMA system, QPSK modulation			
UMTS/TM2	HSDPA system, QPSK modulation			

4.2 Test Environment

Environment Parameter	ment Parameter Selected Values During Tests		
Relative Humidity	Ambient		
Temperature	TN Ambient		
	VL	3.3V	
Voltage	VN	3.8V	
	VH	4.2V	

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



4.3 Test Frequency

Toot Mode	TV / DV	RF Channel				
Test Mode	TX/RX	Low (L)	Middle (M)	High (H)		
	TX	Channel 4132	Channel 4182	Channel 4233		
WCDMA850	17	826.4MHz	836.4MHz	846.6MHz		
WCDIVIA650	RX	Channel 4357	Channel 4407	Channel 4458		
		871.4MHz	881.4MHz	891.6MHz		
	TV	Channel 9262	Channel9400	Channel9538		
WCDM44000	TX	1852.4MHz	1880.0MHz	1907.6MHz		
WCDMA1900	DV	Channel 9662	Channel 9800	Channel 9938		
	RX	1932.4 MHz	1960.0 MHz	1987.6 MHz		



4.4 DESCRIPTION OF TESTS

4.4.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-C-2004. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT.

The power of the emission is calculated using the following formula:

Pd [dBm] = Pg [dBm] - cable loss [dB] + antenna gain [dBd/dBi]

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]).

Test Procedures Used

KDB 971168 v02r02-Section 5.2.1 / KDB 971168 v02R02-Section 5.8

ANSI/TIA-603-C-2004-Section 2.2.17 / ANSI/TIA-603-C-2004-Section 2.2.12

Note: Reference test setup 3



4.4.2 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Test Procedures Used

KDB 971168 v02r02-Section 5.7.1

Test Settings

- 1. The signal analyzer's CCDF measurement profile enabled
- 2. Frequency= carrier center frequency
- 3. Measurement BW > EBW of signal
- 4, for continuous transmissions, set to 1ms
- 5. Record the maximum PAPR level associated with a probability of 0.1%.

Note: Reference test setup 1



4.4.3 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Test Procedures Used

KDB 971168 v02r02-Section 4.2

Test Settings

- 1、SET RBW=1-5% of OBW
- 2、SET VBW ≥ 3*RBW
- 3. Detector: Peak
- 4. Trace mode= max hold.
- 5. Sweep= auto couple
- 6. Steps 1-5 were repeated after it is stable

Note: Reference test setup 1.



4.4.4 Band Edge Compliance

the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission power must be attenuated below the transmitting power (P) by a factor of at least 43+10log₁₀P dB.

Test Procedures Used

KDB 971168 v02r02-Section 6.0

Test Settings

- 1、SET RBW ≥ 1% of Emission BW.
- 2. SET VBW about three times of RBW
- 3. Detector: RMS
- 4. Trace mode= max hold.
- 5 Span= 2MHz

Note: Reference test setup 1.



4.4.5 Spurious and Harmonic Emissions at Antenna Terminal

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Test Procedures Used

KDB 971168 v02r02-Section 6.0

Test Settings

1. $9kHz\sim150kHz$, RBW = 1KHz, VBW $\geq 3\times RBW$,

150kHz~30MHz, RBW = 10KHz, VBW $\geq 3 \times$ RBW,

 $30MHz\sim1GHz$, RBW = 100 kHz, VBW = 300 kHz.

Above 1GHz, RBW = 1 MHz, VBW = 3 MHz.

- 2. Detector: Peak
- 3. Trace mode= max hold.

Note: Reference test setup 1.



4.4.6 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Procedures Used

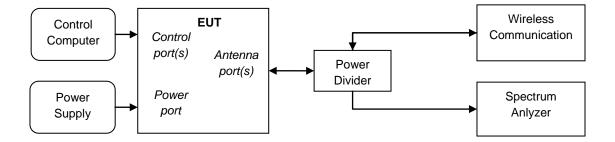
ANSI/TIA-603-C-2004

Note: Reference test setup 2.



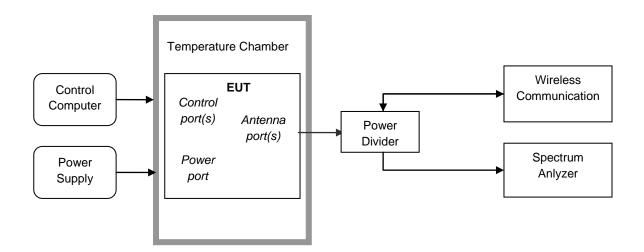
4.5 Test Setups

4.5.1 Test Setup 1





4.5.2 Test Setup 2

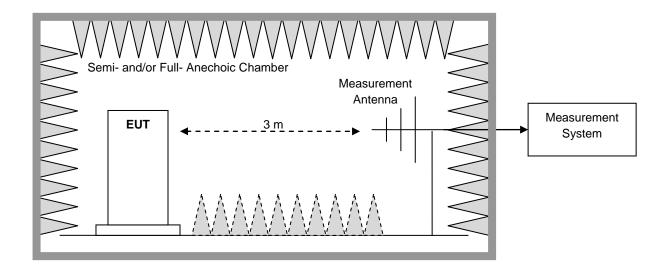




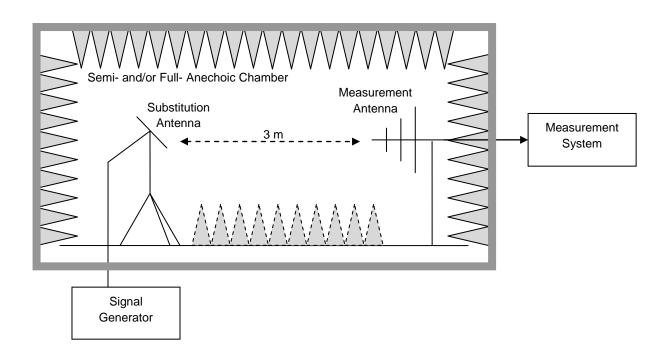
4.5.3 Test Setup 3

NOTE: Effective radiated power (ERP) and Equivalent Isotropic Radiated Power(EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

4.5.3.1 Step 1: Pre-test



4.5.3.2 Step 2: Substitution method to verify the maximum ERP/EIRP





4.6 Test Conditions

Test Case		Test Condition	s	
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
Output	Total	Test Setup	Test Seup 1	
Power Data		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
	Spectral Density	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
Peak-to-Avera	age Ratio	Test Env.	Ambient Climate & Rated Voltage	
(if required)		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
Modulation Characteristics		Test Env.	Ambient Climate & Rated Voltage	
			Test Seup 1	
		RF Channels	М	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
Bandwidth	Occupied	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
	Emission	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
Band Edges (Compliance	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Seup 1	
		RF Channels	L, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1	
Spurious Emi	ssion at Antenna	Test Env.	Ambient Climate & Rated Voltage	
Terminals		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	



Test Case	Test Condition	s			
	Test Mode	UMTS/TM1,LTE/TM1			
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage			
Radiation	Test Setup	Test Seup 3			
	Test Mode	UMTS/TM1/TM2			
		NOTE: If applicable, the EUT conf. that has maximum power			
		density (based on the equivalent power level) is			
		selected.			
	RF Channels	L, M, H			
	(TX)	(L= low channel, M= middle channel, H= high channel)			
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;			
		(2) VL, VN and VH of Rated Voltage at Ambient Climate.			
	Test Setup	Test Seup 2			
	RF Channels	ls L, M, H			
	(TX)	(L= low channel, M= middle channel, H= high channel)			
	Test Mode	UMTS/TM1,LTE/TM1			



5 <u>Main Test Instruments</u>

Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal- Due
Power supply	KEITHLEY	2303	1342889	2015-09-16	2017-09-15
Wireless Communication Test set	Agilent	N4010A	MY49081592	2015-10-30	2016-10-29
Universal Radio Communication Tester	R&S	CMU200	123299	2015-10-30	2016-10-29
Spectrum Analyzer	Agilent	N9020A	MY52090652	2015-07-08	2016-07-07
Universal Radio Communication Tester	R&S	CMW500	126854	2015-02-13	2016-02-12
Spectrum Analyzer	Agilent	E4440A	MY48250119	2015-07-08	2016-07-07
Signal Analyzer	R&S	FSQ31	200021	2015-10-30	2016-10-29
Spectrum Analyzer	Agilent	N9030A	MY49431698	2015-10-30	2016-10-29
Temperature Chamber	WEISS	WKL64	5624600294001 0	2015-02-13	2016-02-12
Signal generator	Agilent	E8257D	MY49281095	2015-10-30	2016-10-29
Vector Signal Generator	R&S	SMU200A	104162	2015-10-30	2016-10-29
Test receiver	R&S	ESU26	100387	2015-6-24	2016-06-23
Test receiver	R&S	ESCI	101163	2015-6-24	2016-06-23
Spectrum analyzer	R&S	FSU3	200474	2015-06-15	2016-06-14
Spectrum analyzer	R&S	FSU43	100144	2015-06-15	2016-06-14
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100262	2015-4-30	2017-4-29
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100263	2015-4-30	2017-4-29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBE CK	VULB 9163	9163-490	2015-4-30	2017-4-29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBE CK	VULB 9163	9163-520	2015-4-30	2017-4-29
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2015-4-30	2017-4-29
double ridged horn antenna (0.8G-18GHz)	R&S	HF907	100305	2015-4-30	2017-4-29
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	5140299	2015-7-15	2017-7-14
Artificial Main Network	R&S	ENV4200	100134	2015-6-24	2016-6-23
Line Impedance Stabilization Network	R&S	ENV216	100382	2015-6-24	2016-6-23
Signal Generator	Agilent	E4438C	MY49071538	2015-03-10	2016-03-09
Power Detecting & Sampling Unit	R&S	OSP-B157	100914	2015-07-27	2016-07-26



6 <u>Measurement Uncertainty</u>

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmit Output Power Data	Power [dBm]	U = 0.39 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 2.0 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
		For 10 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.21 ppm

END